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**Calculational Study of the Z-Pinch Dynamics of Resistively Thick Aluminum Rods** SETH KREHER, University of Nevada, Reno, CHRIS ROUSCULP, Los Alamos National Laboratory, BRUNO BAUER, University of Nevada, Reno — The fundamental limits of high-current conduction are of interest to magnetically driven ICF and other applications. Nonlinear Ohmic heating and conductor motion lead to instabilities such as the Electrothermal Instability (ETI) and Magneto-Rayleigh Taylor (MRT) that disrupt current flow. Here, the LANL, resistive MHD code, FLAG, is used to model, well-diagnosed, uncoated Al rod loads ( $R_0 \sim 400 \mu\text{m} > \text{skin-depth}$ ) in a Z-pinch configuration fielded on the Sandia Mykonos pulse generator ( $t_{\text{rise}} \sim 0.1 \mu\text{s}$ ,  $I_{\text{peak}} \sim 1 \text{ MA}$ ). Results are compared to PDV measurements. Initial rod compression due to Lorentz forces in the solid-state agree well with experiments. After melt, during expansion, results with a tabular EOS that utilizes Maxwell constructs in the bi-phase region show better agreement to data than ones with Van der Waals loops. As predicted, the state of the outer layer of the rod follows the liquid/vapor coexistence curve. Finally, calculational sensitivity to EOS and conductivity are studied to better understand the expansion dynamics.

Seth Kreher  
University of Nevada, Reno

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